SDAS009C - MARCH 1984 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

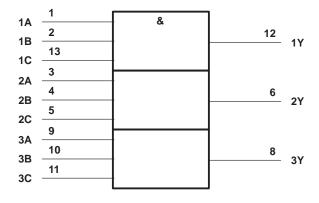
These devices contain three independent 3-input positive-AND gates. They perform the Boolean functions $Y = A \cdot B \cdot C$ or $Y = \overline{A} + \overline{B} + \overline{C}$ in positive logic.

The SN54ALS11A and SN54AS11 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS11A and SN74AS11 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INPUTS	OUTPUT	
Α	В	С	Y
Н	Н	Н	Н
L	X	Χ	L
Х	L	Χ	L
Х	X	L	L

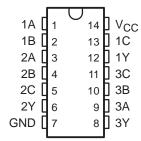
logic symbol†



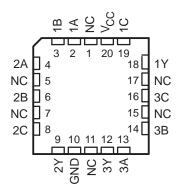
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

SN54ALS11A, SN54AS11 . . . J PACKAGE SN74ALS11A, SN74AS11 . . . D OR N PACKAGE (TOP VIEW)

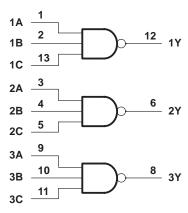


SN54ALS11A, SN54AS11 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



STRUMENTS

SN54ALS11A, SN54AS11, SN74ALS11A, SN74AS11 TRIPLE 3-INPUT POSITIVE-AND GATES

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}		7 V
Input voltage, V _I		7 V
	SN54ALS11A	
	SN74ALS11A	0°C to 70°C
Storage temperature range		-65°C to 150°C

recommended operating conditions

		SN	54ALS1	1A	SN	74ALS1	1A	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
\/	Low-level input voltage			0.8 0.8	V			
VIL	Low-level input voitage			0.7§				V
loн	High-level output current			-0.4			-0.4	mA
loL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

[‡] Applies over temperature range –55°C to 70°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	NDITIONS	SN	SN54ALS11A			SN74ALS11A			
PARAMETER	1251 00	INDITIONS	MIN	TYP¶	MAX	MIN	N TYP¶ MAX		UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{\parallel} = -18 \text{ mA}$			-1.5			-1.5	V	
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		V	
Voi	V _{CC} = 4.5 V	I _{OL} = 4 mA		0.25	0.4		0.25	0.4	0.4 V	
VOL	VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	V	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
lН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
IIГ	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.1			-0.1	mA	
l _O #	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-20		-112	-30		-112	mA	
ICCH	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		1	1.8		1	1.8	mA	
ICCL	V _{CC} = 5.5 V,	V _I = 0		1.6	3		1.6	3	mA	

[¶] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] Applies over temperature range 70°C to 125°C

[#] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX † SN54ALS11A SN74ALS1			UNIT	
			MIN	MAX	MIN	MAX	
t _{PLH}	A, B, or C	V	2	14	2	13	nc
t _{PHL}	А, Б, 01 С	1	2	12.5	2	10	ns

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	
Input voltage, V _I	
Operating free-air temperature range, T _A : SN54AS11	
SN74AS11	0°C to 70°C
Storage temperature range	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		S	N54AS1	1	S	N74AS1	ı	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		s	SN54AS11			SN74AS11			
PARAMETER	1231 0	TEST CONDITIONS		TYP§	MAX	MIN	TYP§	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{ } = -18 \text{ mA}$			-1.2			-1.2	V	
V _{OH}	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	!		V	
V _{OL}	V _{CC} = 4.5 V,	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V	
lį	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA	
lін	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
l _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.5			-0.5	mA	
ΙΟ [¶]	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
Іссн	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		4.3	7		4.3	7	mA	
l _{CCL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0		11.2	18		11.2	18	mA	

[§] All typical values are at V_{CC} = 5 V, T_A = 25°C.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SN54ALS11A, SN54AS11, SN74ALS11A, SN74AS11 TRIPLE 3-INPUT POSITIVE-AND GATES

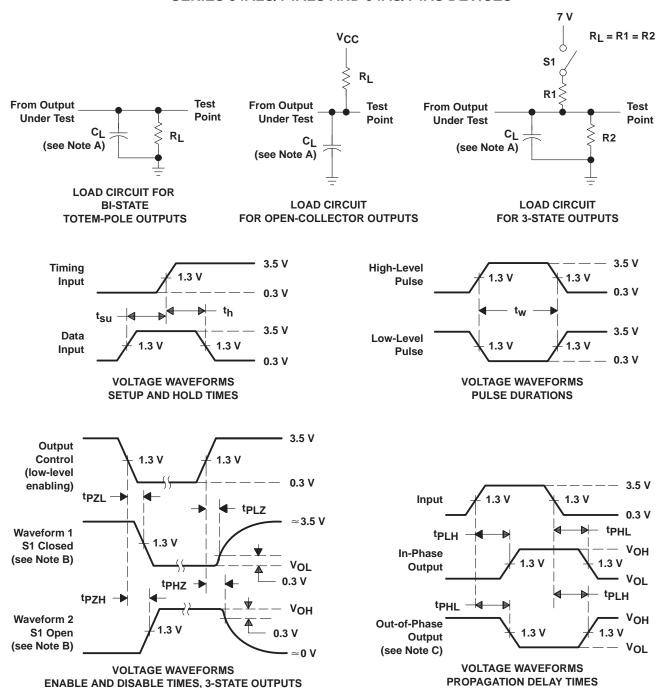
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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R _L T _A	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX† SN54AS11 SN74AS1			UNIT
			MIN	MAX	MIN	MAX	1 1
t _{PLH}	A, B, or C	V	1	6.5	1	6	ns
^t PHL	Α, Β, ΟΙ Ο		1	6.5	1	5.5	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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